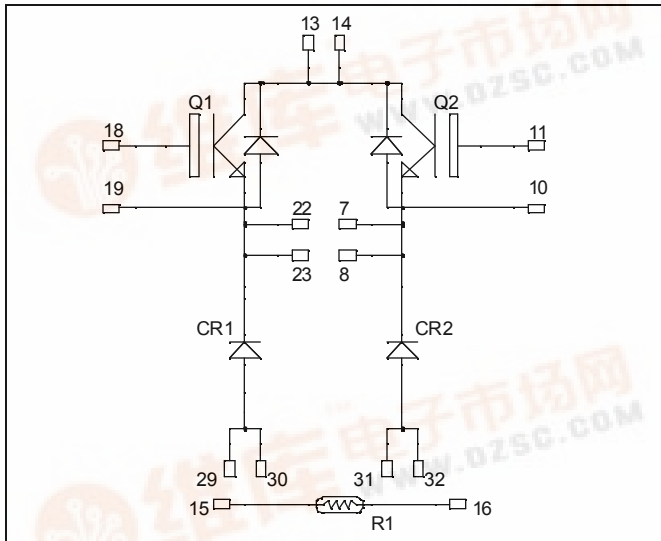




APTGF25DSK120T3G

Dual Buck chopper NPT IGBT Power Module

$V_{CES} = 1200V$
 $I_C = 25A @ T_c = 80^\circ C$



Application

- AC and DC motor control
- Switched Mode Power Supplies

Features

- Non Punch Through (NPT) Fast IGBT®
 - Low voltage drop
 - Low tail current
 - Switching frequency up to 50 kHz
 - Soft recovery parallel diodes
 - Low diode VF
 - Low leakage current
 - Avalanche energy rated
 - RBSOA and SCSOA rated
 - Symmetrical design
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring



All multiple inputs and outputs must be shorted together
Example: 13/14 ; 29/30 ; 22/23 ...

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Solderable terminals both for power and signal for easy PCB mounting
- Low profile
- Easy paralleling due to positive TC of VCEsat
- Each leg can be easily paralleled to achieve a single buck of twice the current capability.
- RoHS compliant

Absolute maximum ratings

Symbol	Parameter	Max ratings	Unit
V_{CES}	Collector - Emitter Breakdown Voltage	1200	V
I_C	Continuous Collector Current	$T_C = 25^\circ C$ 40 $T_C = 80^\circ C$ 25	A
I_{CM}	Pulsed Collector Current	$T_C = 25^\circ C$ 100	A
V_{GE}	Gate - Emitter Voltage	± 20	V
P_D	Maximum Power Dissipation	$T_C = 25^\circ C$ 208	W
RBSOA	Reverse Bias Safe Operating Area	$T_j = 125^\circ C$ 50A@1150V	

All ratings @ $T_j = 25^\circ\text{C}$ unless otherwise specified

Electrical Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
I_{CES}	Zero Gate Voltage Collector Current	$V_{GE} = 0\text{V}$ $V_{CE} = 1200\text{V}$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$			250 500	μA
$V_{CE(sat)}$	Collector Emitter saturation Voltage	$V_{GE} = 15\text{V}$ $I_C = 25\text{A}$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$	2.5	3.2 4.0	3.7	V
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 1\text{mA}$		4		6	V
I_{GES}	Gate – Emitter Leakage Current	$V_{GE} = 20\text{V}, V_{CE} = 0\text{V}$				400	nA

Dynamic Characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
C_{ies}	Input Capacitance	$V_{GE} = 0\text{V}$			1650		pF
C_{oes}	Output Capacitance	$V_{CE} = 25\text{V}$			250		
C_{res}	Reverse Transfer Capacitance	$f = 1\text{MHz}$			110		
Q_g	Total gate Charge	$V_{GE} = 15\text{V}$			160		nC
Q_{ge}	Gate – Emitter Charge	$V_{Bus} = 300\text{V}$			10		
Q_{gc}	Gate – Collector Charge	$I_C = 25\text{A}$			70		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (25°C)			60		ns
T_r	Rise Time	$V_{GE} = 15\text{V}$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 400\text{V}$			305		
T_f	Fall Time	$I_C = 25\text{A}$ $R_G = 22\Omega$			30		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching (125°C)			60		ns
T_r	Rise Time	$V_{GE} = 15\text{V}$			50		
$T_{d(off)}$	Turn-off Delay Time	$V_{Bus} = 400\text{V}$			346		
T_f	Fall Time	$I_C = 25\text{A}$ $R_G = 22\Omega$			40		
E_{on}	Turn-on Switching Energy	$V_{GE} = 15\text{V}$ $V_{Bus} = 400\text{V}$	$T_j = 125^\circ\text{C}$		3.5		mJ
E_{off}	Turn-off Switching Energy	$I_C = 25\text{A}$ $R_G = 22\Omega$	$T_j = 125^\circ\text{C}$		1.5		

Chopper diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	$V_R = 1200\text{V}$	$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$			250 500	μA
I_F	Forward Current		$T_c = 70^\circ\text{C}$		60		A
V_F	Diode Forward Voltage	$I_F = 60\text{A}$			2	2.5	V
		$I_F = 120\text{A}$			2.3		
		$I_F = 60\text{A}$	$T_j = 125^\circ\text{C}$		1.8		
t_{rr}	Reverse Recovery Time	$I_F = 60\text{A}$ $V_R = 800\text{V}$ $di/dt = 200\text{A}/\mu\text{s}$	$T_j = 25^\circ\text{C}$		400		ns
			$T_j = 125^\circ\text{C}$		470		
Q_{rr}	Reverse Recovery Charge		$T_j = 25^\circ\text{C}$ $T_j = 125^\circ\text{C}$		1.2 4		μC

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

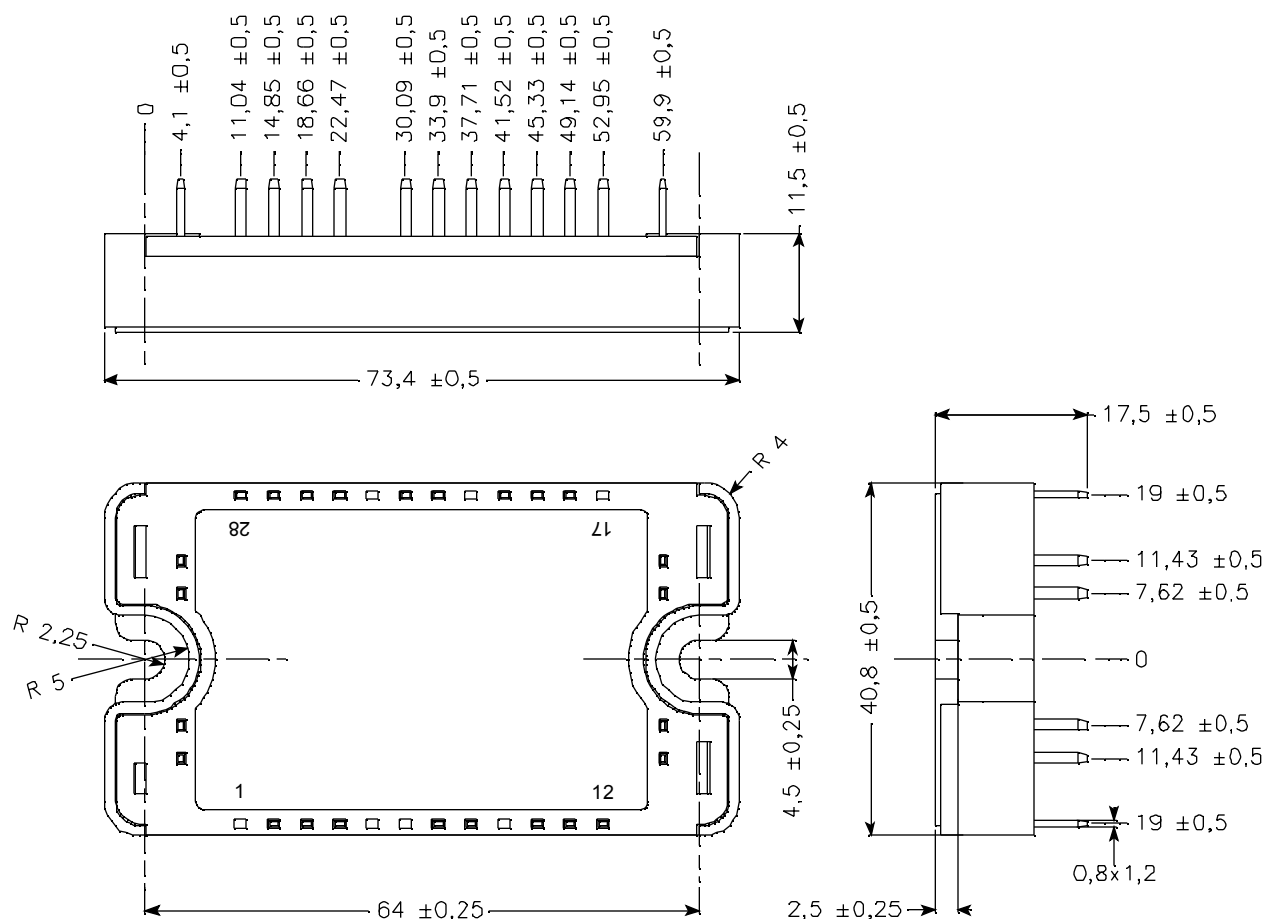
Symbol	Characteristic	Min	Typ	Max	Unit
R ₂₅	Resistance @ 25°C		50		kΩ
B _{25/85}	T ₂₅ = 298.15 K		3952		K

$$R_T = \frac{R_{25}}{\exp \left[B_{25/85} \left(\frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$

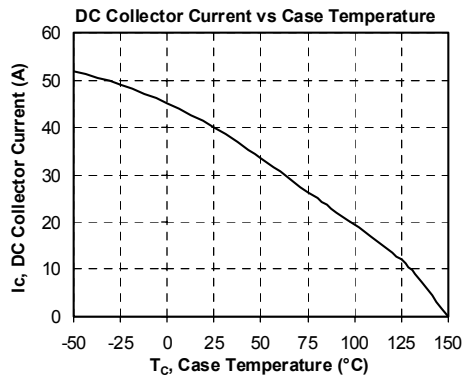
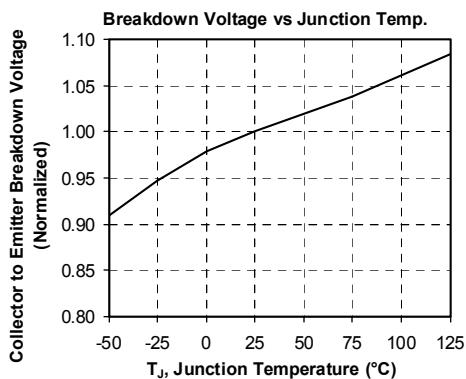
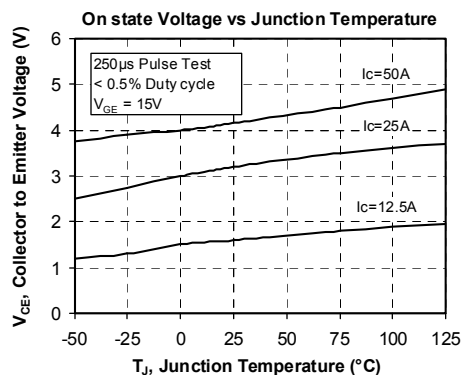
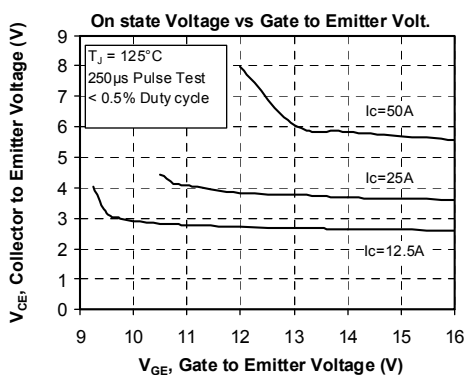
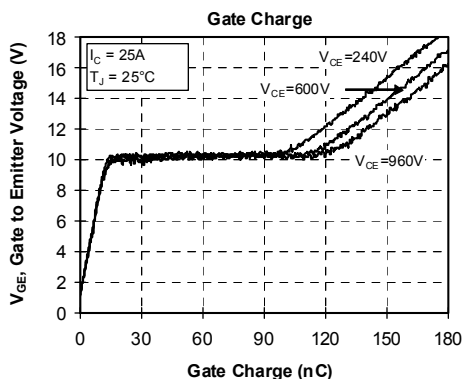
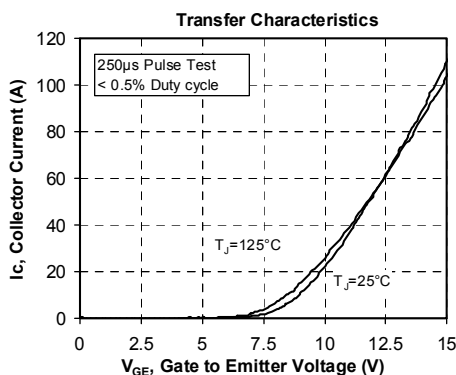
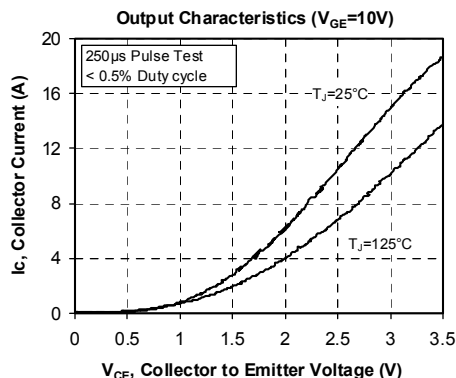
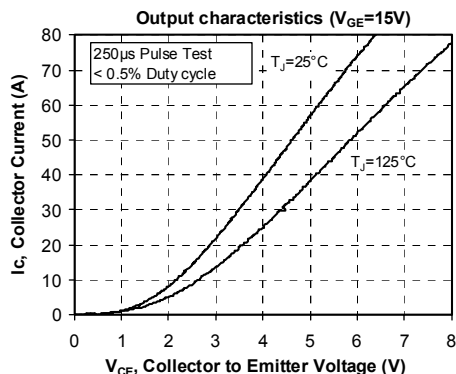
T: Thermistor temperature
 R_T: Thermistor value at T

Thermal and package characteristics

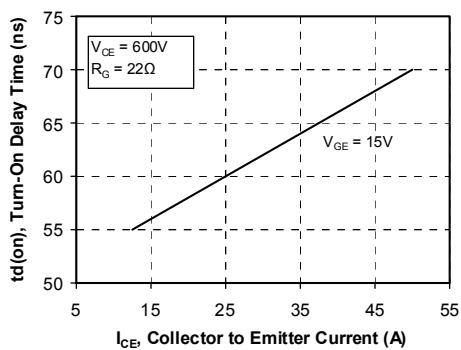
Thermal and package characteristics				Min	Typ	Max	Unit
Symbol	Characteristic						
R _{thJC}	Junction to Case Thermal Resistance			IGBT		0.6	°C/W
				Diode		0.9	
V _{ISOL}	RMS Isolation Voltage, any terminal to case t =1 min, I isol<1mA, 50/60Hz			2500			V
T _J	Operating junction temperature range			-40		150	°C
T _{STG}	Storage Temperature Range			-40		125	
T _C	Operating Case Temperature			-40		100	
Torque	Mounting torque	To heatsink	M4	2.5		4.7	N.m
Wt	Package Weight					110	g

SP3 Package outline (dimensions in mm)

 See application note 1901 - Mounting Instructions for SP3 Power Modules on www.microsemi.com

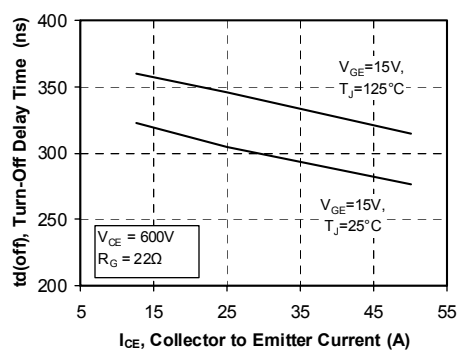
Typical Performance Curve



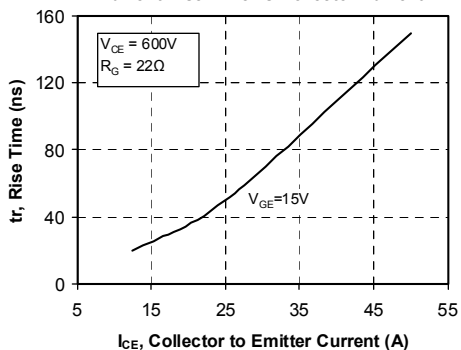
Turn-On Delay Time vs Collector Current



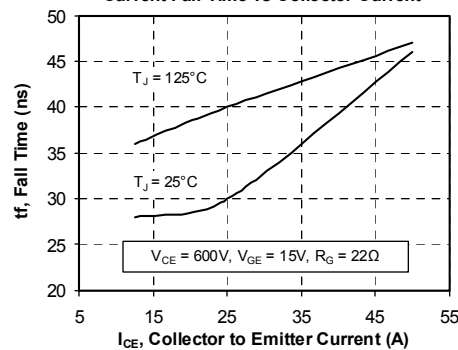
Turn-Off Delay Time vs Collector Current



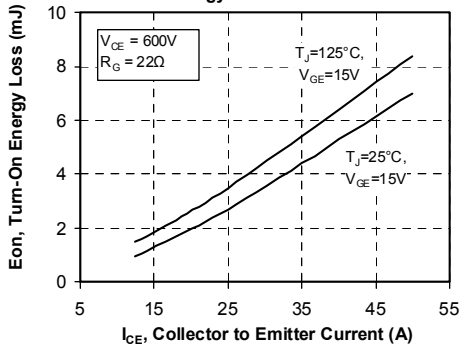
Current Rise Time vs Collector Current



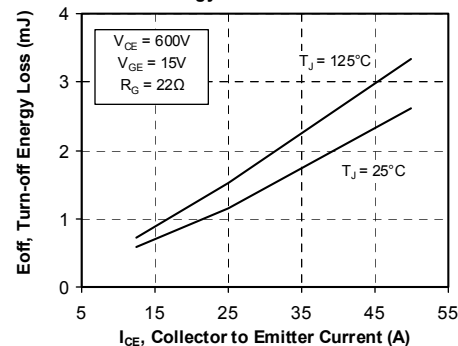
Current Fall Time vs Collector Current



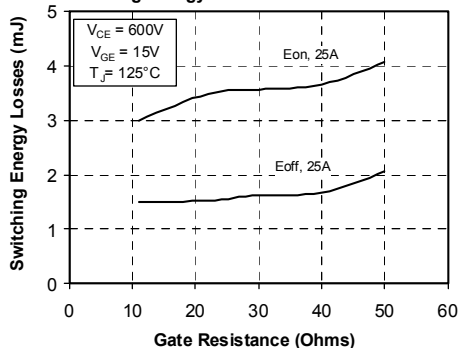
Turn-On Energy Loss vs Collector Current



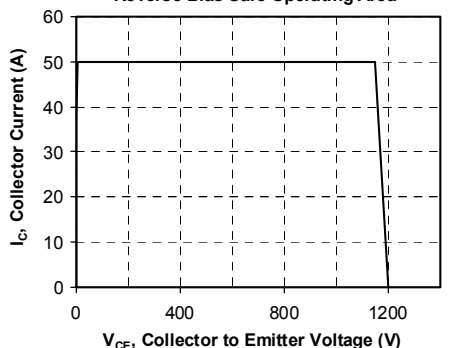
Turn-Off Energy Loss vs Collector Current

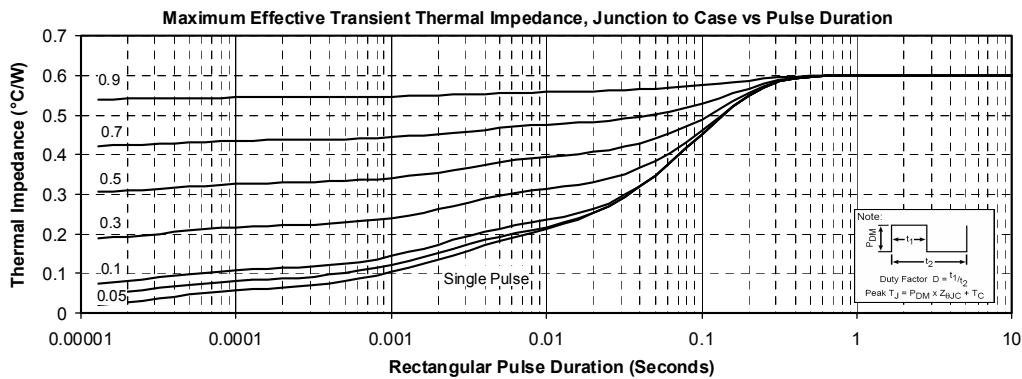
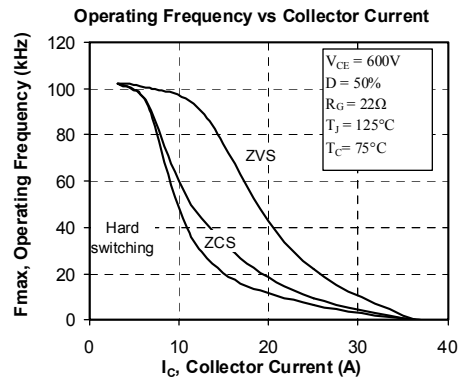
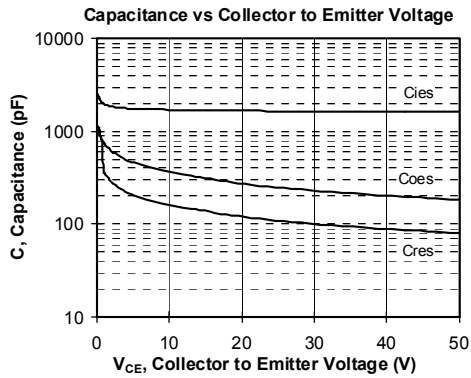


Switching Energy Losses vs Gate Resistance



Reverse Bias Safe Operating Area





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